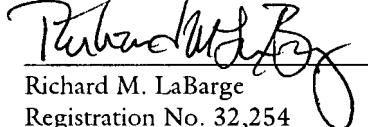




MAY 4 2007

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Mark Leckenby
Ser. No. : 10/516,903
Filed : December 3, 2004
Title : A Method for Determining Field Radiation Levels for a Radiating Device
Art Unit : 3662
Examiner : Alvarado

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) May 1, 2007
) 
) Richard M. LaBarge
Registration No. 32,254
)

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT (IDS)

*Commissioner for Patents
P.O. Box 1450
Alexandria, Virginia 22313-1450*

Dear Sir:

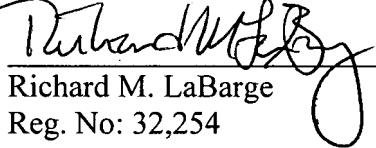
Pursuant to the duty of disclosure under 37 CFR §1.56, the documents identified on the enclosed PTO-1449 form are disclosed to the examiner for consideration in connection with the present application. Copies of the documents identified on the form are enclosed.

This disclosure is being made before the issuance of a first office action. Consequently, no fee is required.

Respectfully submitted,

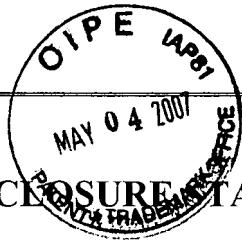
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By:


Richard M. LaBarge
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May 1, 2007

Form PTO-1449 (Modified)

**INFORMATION DISCLOSURE STATEMENT**Atty. Docket No.
28159/40706Serial No.
10/516,903Applicant(s)
Leckenby, MarkFiling Date (International Filing
Date) June 5, 2003Art Unit
3662**U.S. PATENT DOCUMENTS**

Examiner Initials	Document Number	Issue or Publication Date	Name	Class	Subclass	Filing Date (If Appropriate)

FOREIGN PATENT DOCUMENTS

Examiner Initials	Document Number	Publication Date	Country	Translation Yes No

OTHER DOCUMENTS

	Examination report issued by the New Zealand Patent Office dated February 7, 2005
	First examination report issued by the Indian Patent Office dated January 25, 2007
	Translation of the first examination report issued by the Chinese Patent Office
	Examination report issued by the Australian Patent Office dated April 15, 2004

EXAMINER:

DATE CONSIDERED: